MOSFET - SiC Power, Single N-Channel, TO247-4L 1200 V, 160 mΩ, 17.3 A

NVH4L160N120SC1

Features

- Typ. $R_{DS(on)} = 160 \text{ m}\Omega$
- Ultra Low Gate Charge $(Q_{G(tot)} = 34 \text{ nC})$
- High Speed Switching with Low Capacitance ($C_{oss} = 49.5 \text{ pF}$)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Pb-Free and is RoHS Compliant

Typical Applications

- Automotive On Board Charger
- Automotive DC/DC Converter for EV/HEV

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	1200	V
Gate-to-Source Voltage	Gate-to-Source Voltage			-15/+25	V
	Recommended Operation Values of Gate-to-Source Voltage		V_{GSop}	-5/+20	V
Continuous Drain Current (Note 2)	Steady State	T _C = 25°C	I _D	17.3	Α
Power Dissipation (Note 2)			P _D	111	W
Continuous Drain Current (Notes 1, 2)	Steady State	T _C = 100°C	I _D	12.3	Α
Power Dissipation (Notes 1, 2)			P _D	55.5	W
Pulsed Drain Current (Note 3)	T _A = 25°C		I _{DM}	69	Α
Single Pulse Surge Drain Current Capability	T_A = 25°C, t_p = 10 μ s, R_G = 4.7 Ω		I _{DSC}	140	Α
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C	
Source Current (Body Diode)			Is	11	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 16 A, L = 5 mH) (Note 4)			E _{AS}	128	mJ
Maximum Lead Temperature for Soldering (1/8" from case for 5 s)			TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- JA is constant value to follow guide table of LV/HV discrete final datasheet generation.
- generation.

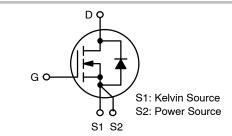
 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. Repetitive rating, limited by max junction temperature.
- 4. EAS of 128 mJ is based on starting $T_J = 25^{\circ}C$; L = 5 mH, $I_{AS} = 16$ A, $V_{DD} = 120$ V, $V_{GS} = 18$ V.



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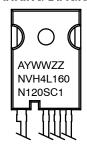
V _{(B}	R)DSS	R _{DS(ON)} MAX	I _D MAX	
12	00 V	224 mΩ @ 20 V	17.3 A	



N-CHANNEL MOSFET



MARKING DIAGRAM



A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

NVH4L160N120SC1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping			
NVH4L160N120SC1	TO247-4L	30 ea / Tube			

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ heta JC}$	1.35	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{\theta JA}$	40	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	1	•		ı	I		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$		1200	_	_	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to 25°C		-	0.6	-	V/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C	_	_	100	μΑ
		V _{DS} = 1200 V	T _J = 175°C	-	_	1	mA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +25/-15 \text{ V}, V_{D}$	S = 0 V	-	_	±1	μΑ
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} = 2.5 \text{ n}$	nΑ	1.8	3.1	4.3	V
Recommended Gate Voltage	V_{GOP}			-5	-	+20	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 20 V, I _D = 12 A	, T _J = 25°C	-	160	224	mΩ
		V _{GS} = 20 V, I _D = 12 A	, T _J = 175°C	-	271	377	
Forward Transconductance	9FS	V _{DS} = 20 V, I _D = 12 A		-	3.2	-	S
CHARGES, CAPACITANCES & GATE RES	SISTANCE				•		
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 800 V		-	665	-	pF
Output Capacitance	Coss			-	49.5	-	
Reverse Transfer Capacitance	C _{RSS}			-	4.3	-	
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V},$ $I_{D} = 16 \text{ A}$		-	34	-	nC
Threshold Gate Charge	Q _{G(TH)}			-	6	-	
Gate-to-Source Charge	Q_{GS}			-	12.5	-	
Gate-to-Drain Charge	Q_GD			-	9.6	-	
Gate-Resistance	R_{G}	f = 1 MHz		_	1.4	-	Ω
SWITCHING CHARACTERISTICS, VGS =	10 V				•		
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -5/20 \text{ V},$		-	11	20	ns
Rise Time	t _r	V _{DS} = 800 V, I _D = 16 A,		_	10	20	
Turn-Off Delay Time	t _{d(OFF)}	$R_G = 6 \Omega$ inductive load		_	14	25	1
Fall Time	t _f	madenve lead		_	7	14	
Turn-On Switching Loss	E _{ON}	1		_	104	_	μЈ
Turn-Off Switching Loss	E _{OFF}			-	32	-	1
Total Switching Loss	E _{tot}			_	136	-	
DRAIN-SOURCE DIODE CHARACTERIST	rics				-		
Continuous Drain-Source Diode Forward Current	I _{SD}	$V_{GS} = -5 \text{ V}, T_{J} = 25^{\circ}\text{C}$		-	-	11	Α
Pulsed Drain-Source Diode Forward Current (Note 3)	I _{SDM}			-	-	69	
Forward Diode Voltage	V_{SD}	V _{GS} = -5 V, I _{SD} = 6 A, T _J = 25°C		-	4	_	V

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS							
Reverse Recovery Time	t _{RR}	$V_{GS} = -5/20 \text{ V}, I_{SD} = 16 \text{ A},$	_	15	-	ns	
Reverse Recovery Charge	Q _{RR}	$dI_S/dt = 1000 A/\mu s$	-	47	-	nC	
Reverse Recovery Energy	E _{REC}		-	3.9	-	μJ	
Peak Reverse Recovery Current	I _{RRM}	1	_	6.6	-	Α	
Charge time	Ta]	-	7.0	-	ns	
Discharge time	Tb	1	-	7.4	-	ns	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

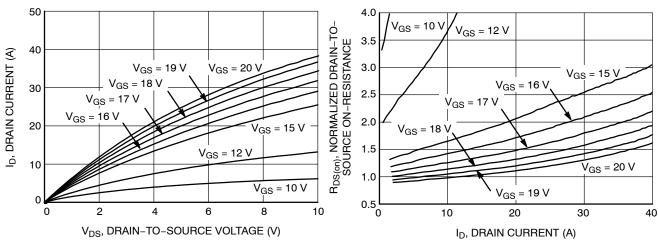


Figure 1. On Characteristics

Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

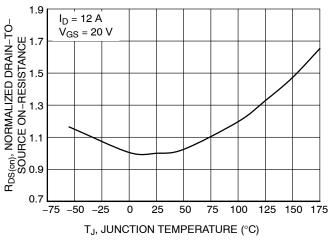


Figure 3. On–Resistance Variation with Temperature

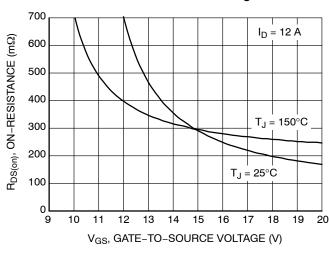


Figure 4. On-Resistance vs. Gate-to-Source Voltage

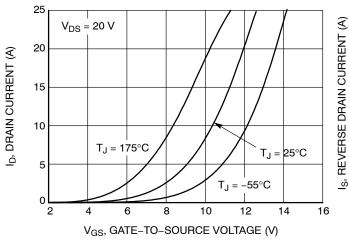


Figure 5. Transfer Characteristics

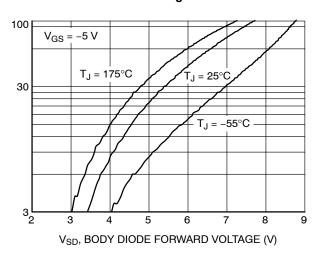


Figure 6. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS

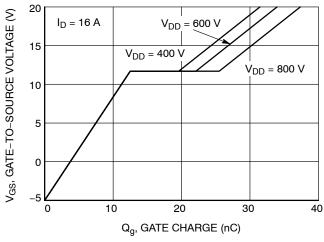


Figure 7. Gate-to-Source Voltage vs. Total Charge

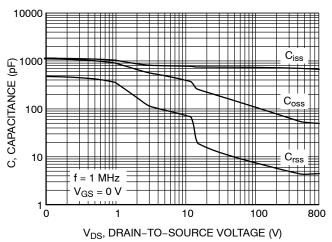


Figure 8. Capacitance vs. Drain-to-Source

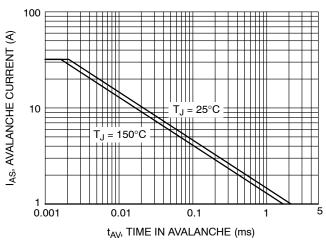


Figure 9. Unclamped Inductive Switching Capability

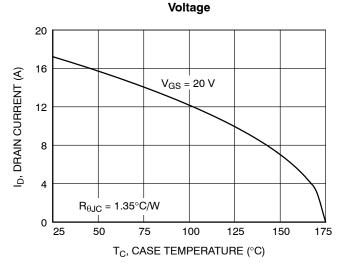


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

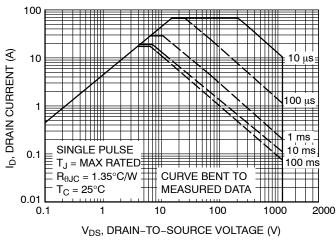


Figure 11. Maximum Rated Forward Biased Safe Operating Area

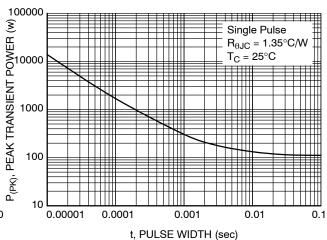


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

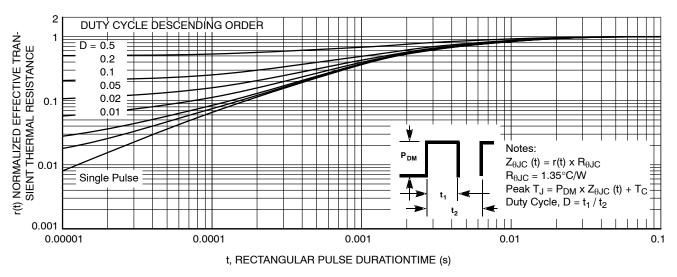
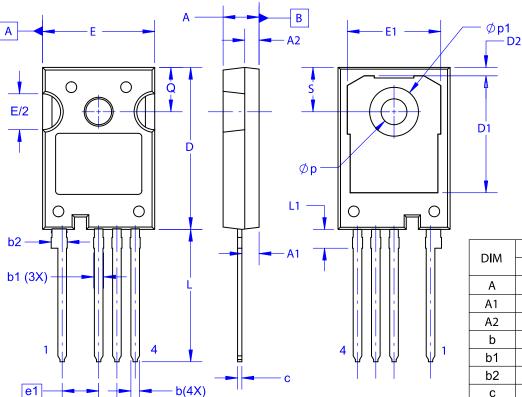


Figure 13. Junction-to-Case Transient Thermal Response Curve

TO-247-4LD CASE 340CJ **ISSUE A**

DATE 16 SEP 2019



NOTES:

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DIM	MIN	NOM	MAX	
A	4.80	5.00	5.20	
A1	2.10	2.40	2.70	
A2	1.80	2.00	2.20	
b	1.07	1.20	1.33	
b1	1.20	1.40	1.60	
b2	2.02	2.22	2.42	
С	0.50	0.60	0.70	
D	22.34	22.54	22.74	
D1	16.00	16.25	16.50	
D2	0.97	1.17	1.37	
е	2.54 BSC			
e1	5	5.08 BSC		
E	15.40	15.60	15.80	
E1	12.80	13.00	13.20	
E/2	4.80	5.00	5.20	
L	18.22	18.42	18.62	
L1	2.42	2.62	2.82	
р	3.40	3.60	3.80	
p1	6.60	6.80	7.00	
Q	5.97	6.17	6.37	
S	5.97	6.17	6.37	

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